

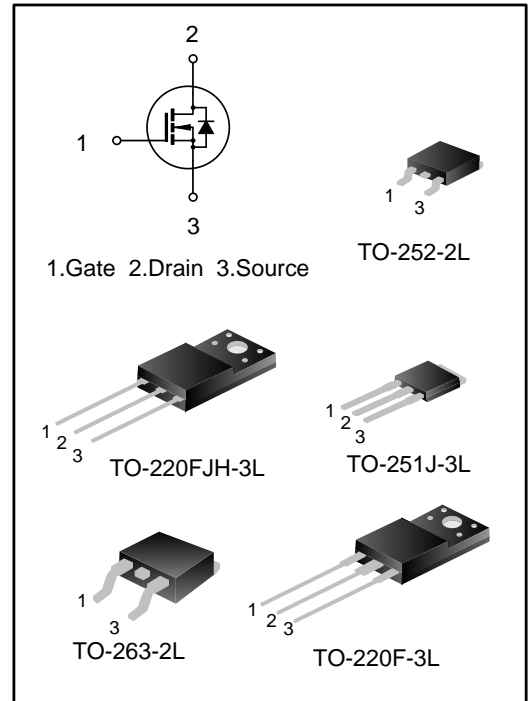
## 11A, 700V SUPER JUNCTION MOS POWER TRANSISTOR

### DESCRIPTION

SVS11N70FJH/D/MJ/S/FD2 is an N-channel enhancement mode high voltage power MOSFETs produced using Silan's super junction MOS technology. It achieves low conduction loss and switching losses. It leads the design engineers to their power converters with high efficiency, high power density, and superior thermal behavior. Furthermore, it's universal applicable, for example, it is suitable for hard and soft switching topologies.

### FEATURES

- ◆ 11A, 700V,  $R_{DS(on)(typ.)}=0.37\Omega@V_{GS}=10V$
- ◆ New revolutionary high voltage technology
- ◆ Ultra low gate charge
- ◆ Enhanced avalanche capability
- ◆ Extreme dv/dt rated
- ◆ High peak current capability



### ORDERING INFORMATION

Part No.	Package	Marking	Hazardous substance control	Packing Type
SVS11N70FJHD2	TO-220FJH-3L	11N70FJH	Halogen free	Tube
SVS11N70DD2TR	TO-252-2L	11N70DD2	Halogen free	Tape & Reel
SVS11N70MJD2	TO-251J-3L	11N70MJD2	Halogen free	Tube
SVS11N70SD2	TO-263-2L	11N70SD2	Halogen free	Tube
SVS11N70FD2	TO-220F-3L	11N70FD2	Halogen free	Tube



**ABSOLUTE MAXIMUM RATINGS (UNLESS OTHERWISE NOTED, T<sub>A</sub>=25°C)**

Characteristics	Symbol	Ratings			Unit
		SVS11N70 FD2/FJHD2	SVS11N70 DD2/MJD2	SVS11N70 SD2	
Drain-Source Voltage	V <sub>DS</sub>	700			V
Gate-Source Voltage	V <sub>GS</sub>	±30			V
Drain Current	I <sub>D</sub>	T <sub>C</sub> =25°C			A
		T <sub>C</sub> =100°C			
Drain Current Pulsed	I <sub>DM</sub>	44			A
Power Dissipation (T <sub>C</sub> =25°C) - Derate above 25°C	P <sub>D</sub>	37	130	139	W
		0.3	1.0	1.1	W/°C
Single Pulsed Avalanche Energy (Note 1)	E <sub>AS</sub>	576			mJ
Reverse diode dv/dt (Note 2)	dv/dt	15			V/ns
MOSFET dv/dt ruggedness (Note 3)	dv/dt	50			V/ns
Operation Junction Temperature Range	T <sub>J</sub>	-55~+150			°C
Storage Temperature Range	T <sub>stg</sub>	-55~+150			°C

**THERMAL CHARACTERISTICS**

Characteristics	Symbol	Ratings			Unit
		SVS11N70 FD2/FJHD2	SVS11N70 DD2/MJD2	SVS11N70 SD2	
Thermal Resistance, Junction-to-Case	R <sub>θJC</sub>	3.4	0.96	0.9	°C/W
Thermal Resistance, Junction-to-Ambient	R <sub>θJA</sub>	62.5	62.5	62.5	°C/W

**ELECTRICAL CHARACTERISTICS (UNLESS OTHERWISE NOTED,  $T_J=25^{\circ}\text{C}$ )**

Characteristics	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Drain -Source Breakdown Voltage	$BV_{DSS}$	$V_{GS}=0V, I_D=250\mu A$	700	--	--	V
Drain-Source Leakage Current	$I_{DSS}$	$V_{DS}=700V, V_{GS}=0V$	--	--	1.0	$\mu A$
Gate-Source Leakage Current	$I_{GSS}$	$V_{GS}=\pm 30V, V_{DS}=0V$	--	--	$\pm 100$	nA
Gate Threshold Voltage	$V_{GS(th)}$	$V_{GS}=V_{DS}, I_D=250\mu A$	2.0	--	4.0	V
Static Drain- Source on State Resistance	$R_{DS(on)}$	$V_{GS}=10V, I_D=5.5A$	--	0.37	0.42	$\Omega$
Gate resistance	$R_g$	$f=1.0\text{MHz}$	--	4.7	--	$\Omega$
Input Capacitance	$C_{iss}$	$f=1\text{MHz}, V_{GS}=0V, V_{DS}=100V$	--	673	--	pF
Output Capacitance	$C_{oss}$		--	37	--	
Reverse Transfer Capacitance	$C_{rss}$		--	2.3	--	
Turn-on Delay Time	$t_{d(on)}$	$V_{DD}=350V, V_{GS}=10V, R_G=24\Omega, I_D=11A$ (Note 4,5)	--	14	--	ns
Turn-on Rise Time	$t_r$		--	37	--	
Turn-off Delay Time	$t_{d(off)}$		--	70	--	
Turn-off Fall Time	$t_f$		--	33	--	
Total Gate Charge	$Q_g$	$V_{DD}=560V, V_{GS}=10V, I_D=11A$ (Note 4,5)	--	24	--	nC
Gate-Source Charge	$Q_{gs}$		--	5.2	--	
Gate-Drain Charge	$Q_{gd}$		--	12	--	

**SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS**

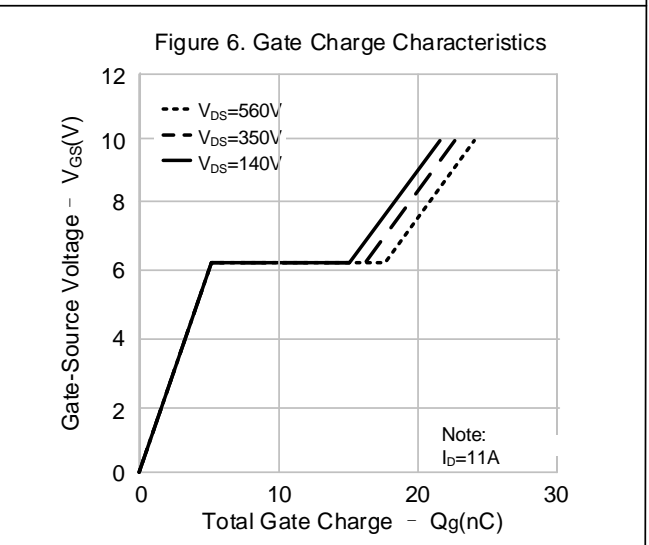
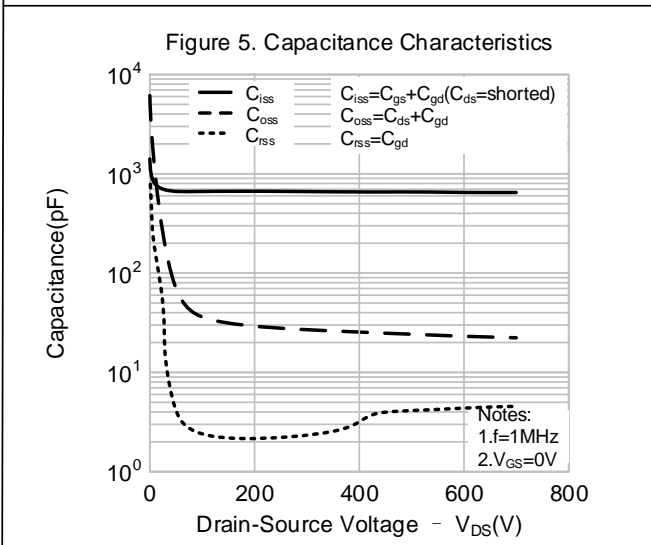
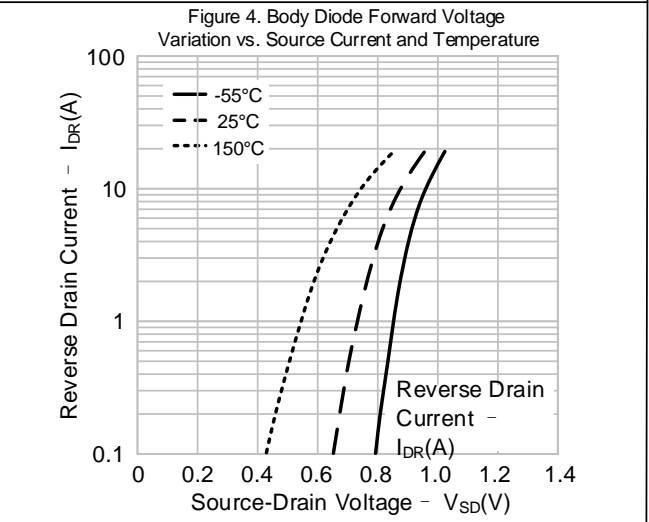
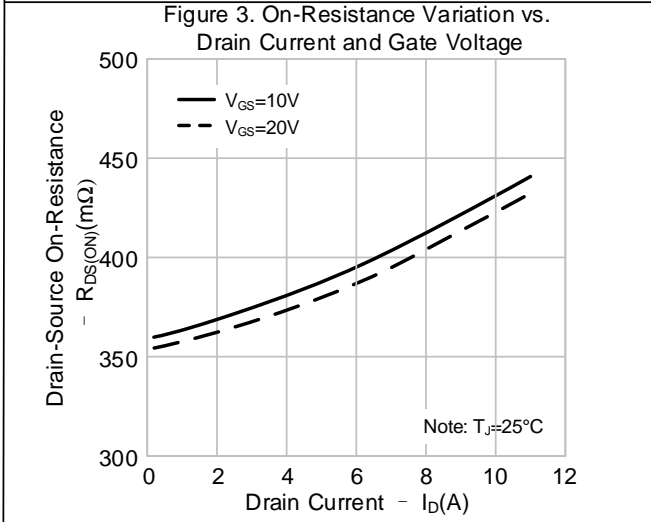
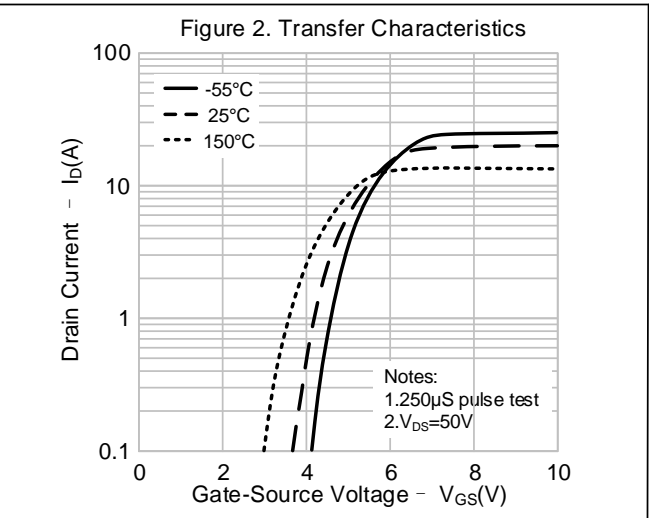
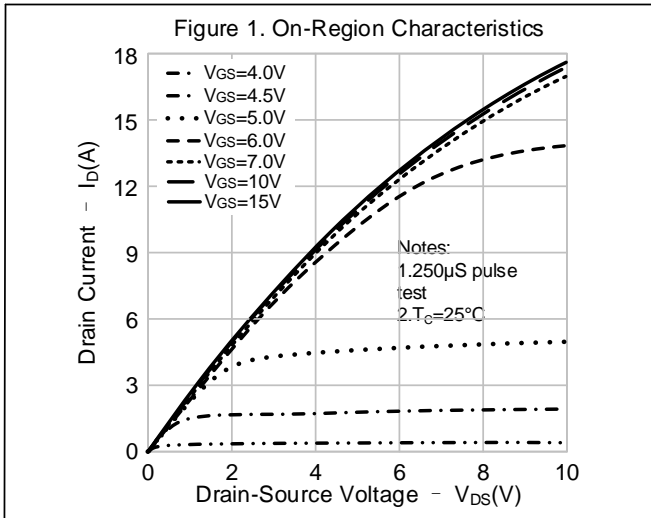
Characteristics	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Continuous Source Current	$I_S$	Integral Reverse P-N Junction Diode in the MOSFET	--	--	11	A
Pulsed Source Current	$I_{SM}$		--	--	44	
Diode Forward Voltage	$V_{SD}$	$I_S=11A, V_{GS}=0V$	--	--	1.4	V
Reverse Recovery Time	$T_{rr}$	$I_S=11A, V_{GS}=0V, dI_F/dt=100A/\mu s$ (Note 4)	--	374	--	ns
Reverse Recovery Charge	$Q_{rr}$		--	3.9	--	$\mu C$

**Notes:**

- $L=79\text{mH}, I_{AS}=3.5A, V_{DD}=100V, R_G=25\Omega$ , starting  $T_J=25^{\circ}\text{C}$ ;
- $V_{DS}=0\sim 400V, I_{SD}\leq 11A, T_J=25^{\circ}\text{C}$ ;
- $V_{DS}=0\sim 480V$ ;
- Pulse Test: Pulse width  $\leq 300\mu s$ , Duty cycles  $\leq 2\%$ ;
- Essentially independent of operating temperature.

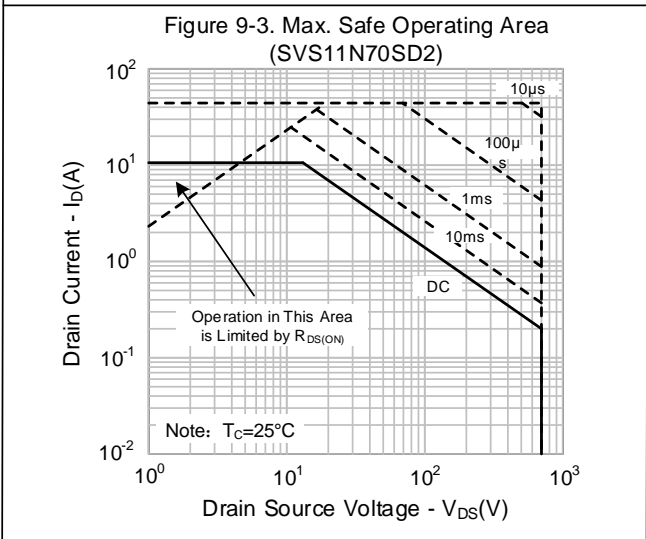
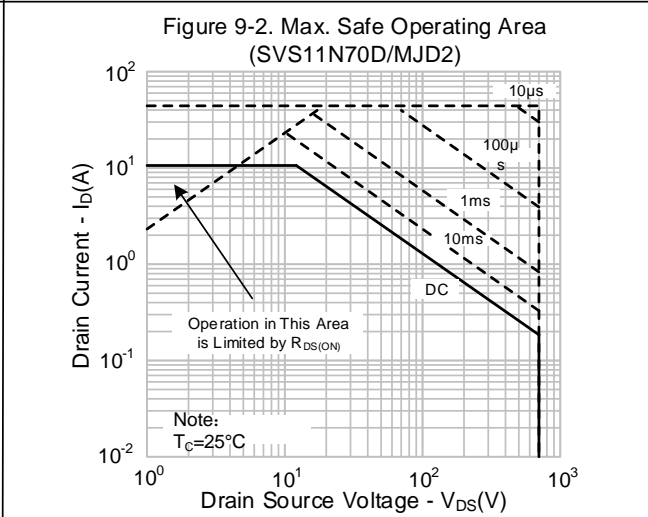
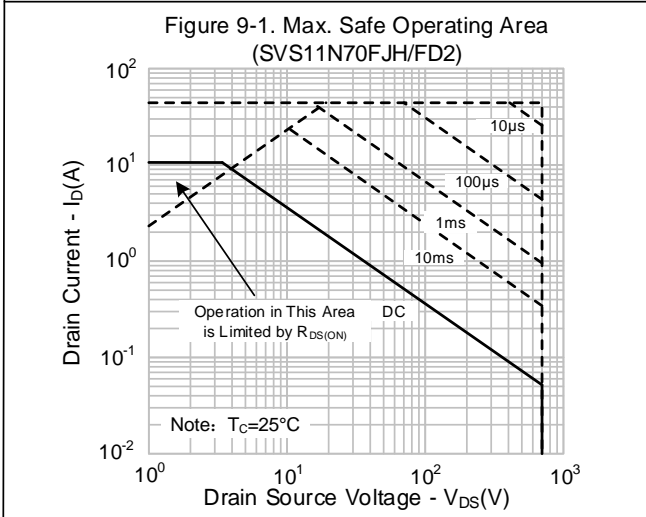
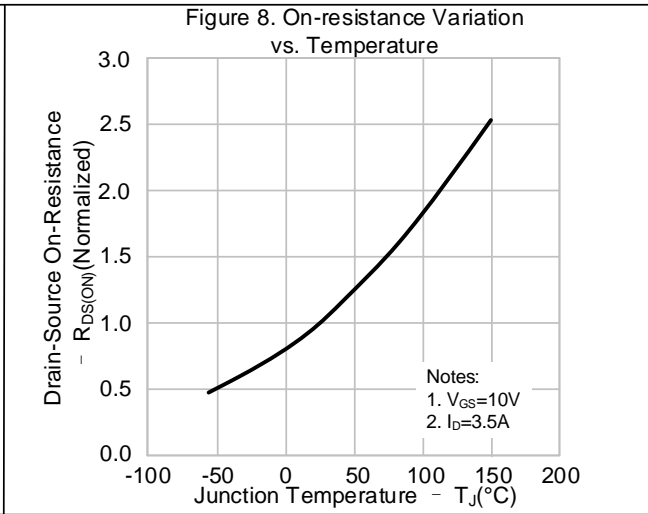
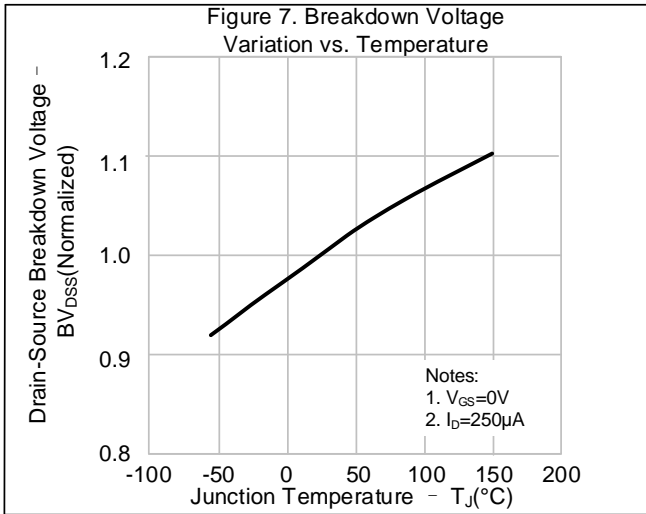


## TYPICAL CHARACTERISTICS



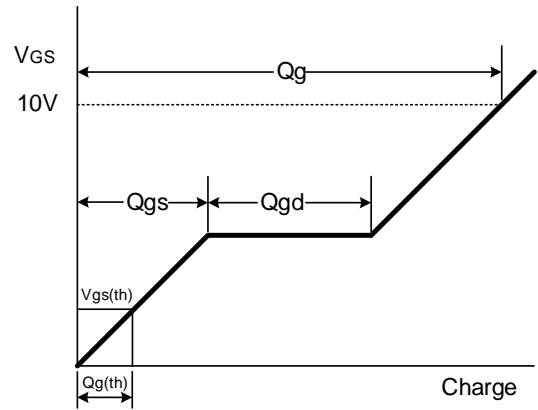
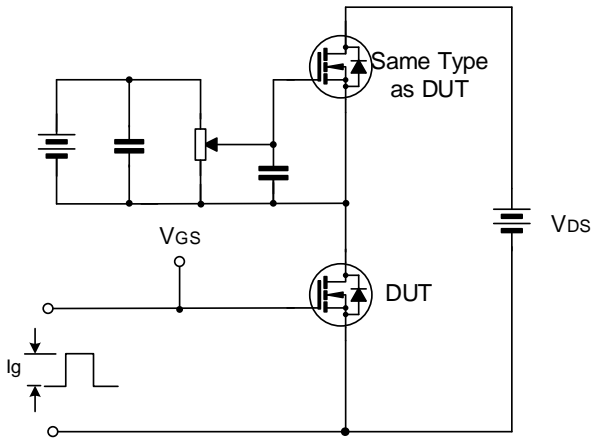


## TYPICAL CHARACTERISTICS (CONTINUED)

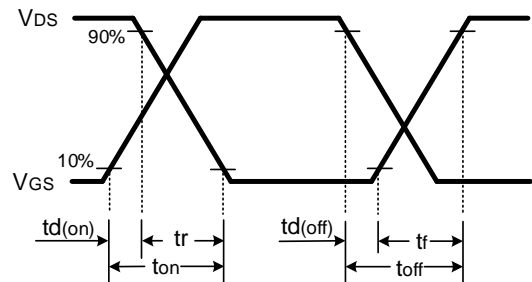
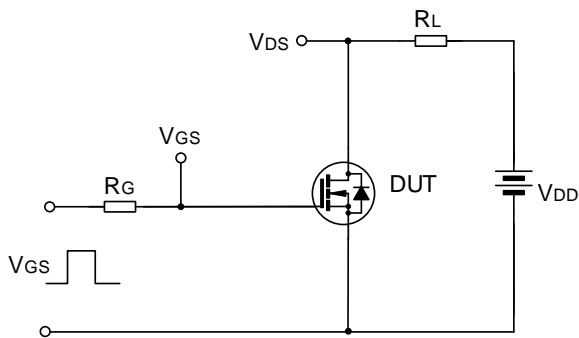


**TYPICAL TEST CIRCUIT**

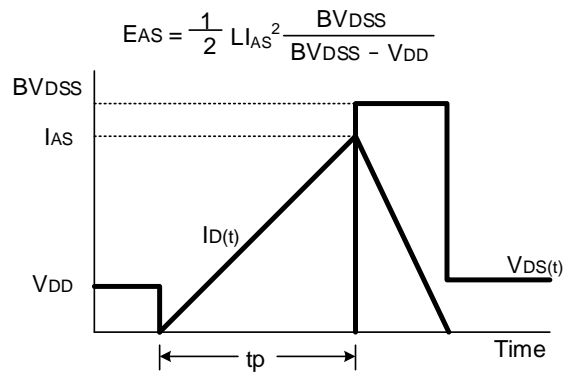
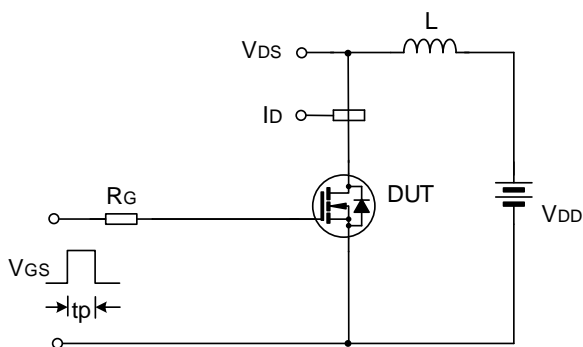
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveform



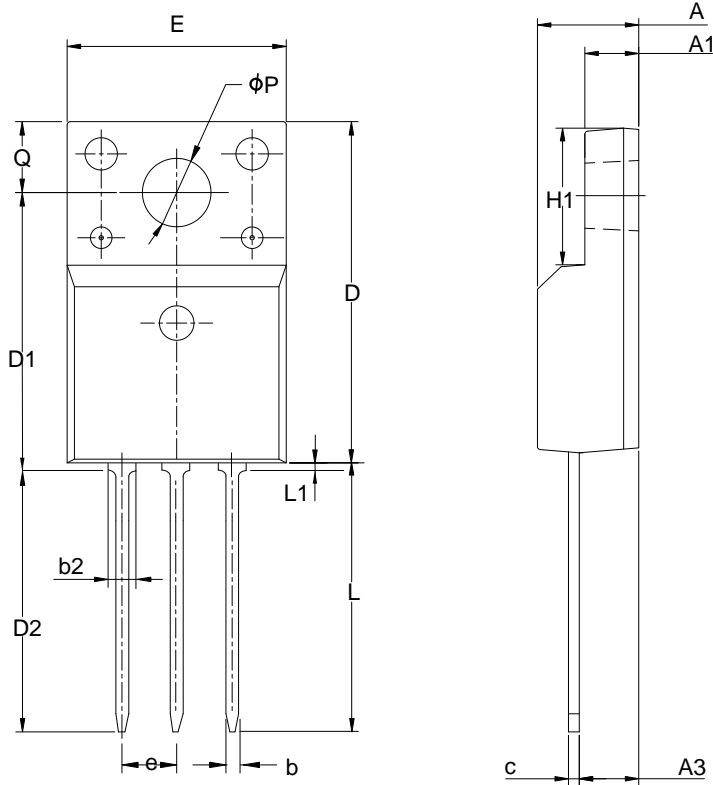
Undamped Inductive Switching Test Circuit & Waveform



**PACKAGE OUTLINE**

**TO-220FJH-3L**

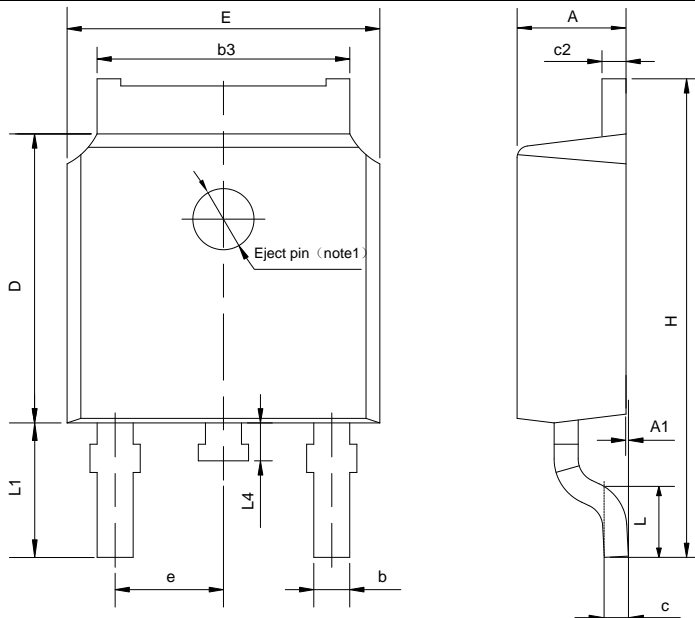
Unit: mm



SYMBOL	MILLIMETER		
	MIN	NOM	MAX
A	4.42	4.70	5.02
A1	2.30	2.54	2.80
A3	2.50	2.76	3.10
b	0.55	0.70	<b>0.80</b>
b2	—	—	1.29
c	0.35	0.50	0.65
D	15.25	15.87	16.25
D1	12.87	13.07	13.27
D2	12.28	12.48	12.68
E	9.73	10.16	10.36
e	2.54BCS		
H1	6.40	6.68	7.00
L	12.48	12.98	13.48
L1	—	—	0.85
$\phi P$	3.00	3.18	3.40
Q	3.05	3.30	3.55

**TO-252-2L**

Unit: mm



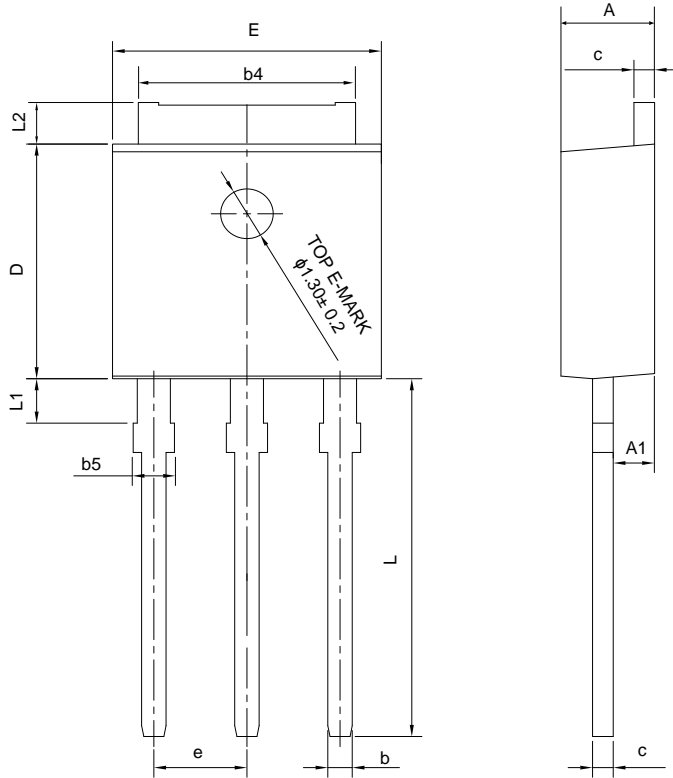
SYMBOL	MILLIMETER		
	MIN	NOM	MAX
A	2.10	2.30	2.50
A1	0	—	0.127
b	0.66	0.76	0.89
b3	5.10	5.33	5.46
c	0.45	—	0.65
c2	0.45	—	0.65
D	5.80	6.10	6.40
E	6.30	6.60	6.90
e	2.30TYP		
H	9.60	10.10	10.60
L	1.40	1.50	1.70
L1	2.90REF		
L4	0.60	0.80	1.00

NOTE1 : There are two conditions for this position:has an eject pin or has no eject pin.

**PACKAGE OUTLINE(CONTINUED)**

Unit: mm

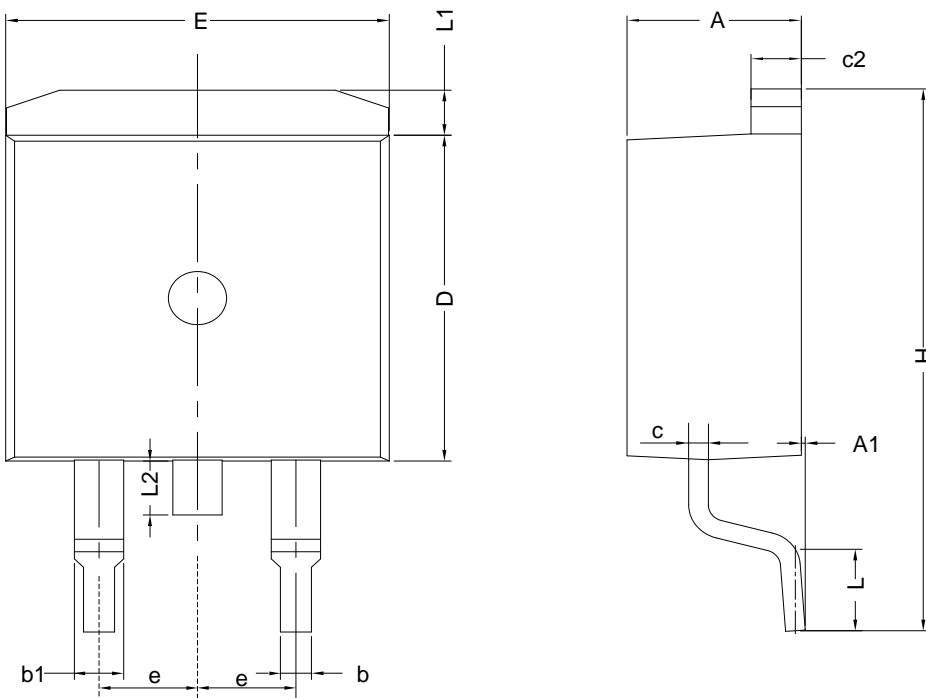
**TO-251J-3L**



SYMBOL	MILLIMETER		
	MIN	NOM	MAX
A	2.18	2.30	2.39
A1	0.89	1.00	1.14
b	0.56	—	0.89
b4	4.95	5.33	5.46
b5	—	—	1.05
c	0.46	—	0.61
D	5.97	6.10	6.27
E	6.35	6.60	6.73
e	2.29 BCS		
L	8.89	9.30	9.65
L1	0.95	—	1.50
L2	0.89	—	1.27

**TO-263-2L**

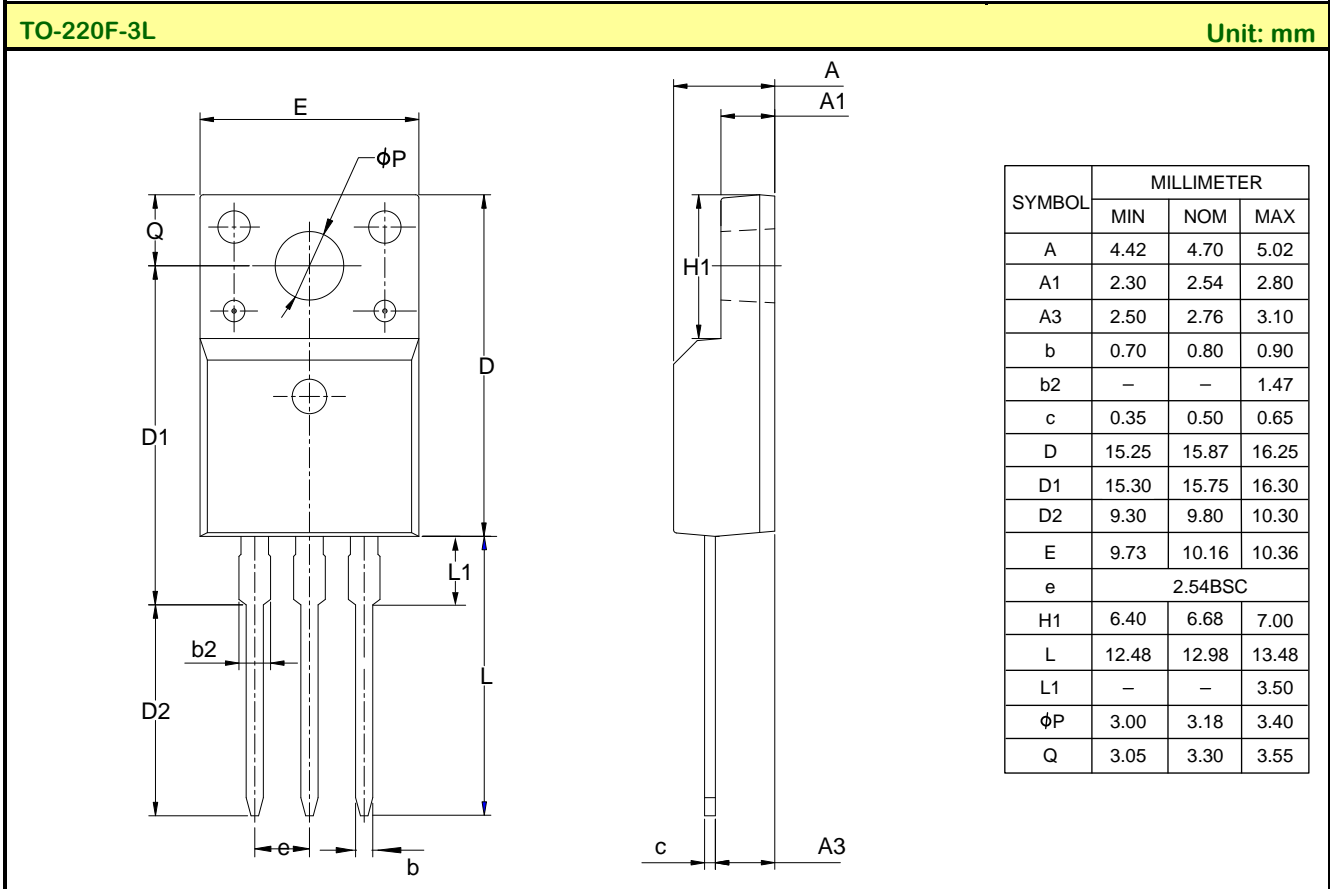
Unit: mm



SYMBOL	MILLIMETER		
	MIN	NOM	MAX
A	4.30	4.57	4.72
A1	0	0.10	0.25
b	0.71	0.81	0.91
c	0.30	—	0.60
c2	1.17	1.27	1.37
D	8.50	—	9.35
E	9.80	—	10.45
e	2.54 BSC		
H	14.70	—	15.75
L	2.00	2.30	2.74
L1	1.12	1.27	1.42
L2	—	—	1.75



**PACKAGE OUTLINE(CONTINUED)**



**Important notice :**

- The instructions are subject to change without notice! Customers should obtain the latest relevant information before placing orders and should verify that such information is complete and current.
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Rev.: 1.2

Revision History:

1. Modify Electrical schematic and TYPICAL TEST CIRCUIT
  2. Deleted NOMENCLATURE
  3. Changed the template
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Rev.: 1.1

Revision History:

1. Add SVS11N70DD2、SVS11N70MJD2、SVS11N70SD2、SVS11N70FD2
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Rev.: 1.0

Revision History:

1. First release
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